SN54ABT843 . . . JT OR W PACKAGE

SN74ABT843 . . . DB, DW, OR NT PACKAGE

(TOP VIFW)

SCBS197D - FEBRUARY 1991 - REVISED MAY 1997

- State-of-the-Art *EPIC*-II*B*<sup>™</sup> BiCMOS Design Significantly Reduces Power Dissipation
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Typical V<sub>OLP</sub> (Output Ground Bounce) < 1 V at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C
- High-Drive Outputs (–32-mA I<sub>OH</sub>, 64-mA I<sub>OL</sub>)
- Package Options Include Plastic Small-Outline (DW) and Shrink Small-Outline (DB) Packages, Ceramic Chip Carriers (FK), Ceramic Flat (W) Package, and Plastic (NT) and Ceramic (JT) DIPs

#### description

The 'ABT843 9-bit latches are designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

The nine transparent D-type latches provide true data at the outputs.

A buffered output-enable  $(\overline{OE})$  input can be used to place the nine outputs in either a normal logic state (high or low logic levels) or a high-impedance state. The outputs are also in the high-impedance state during power-up and power-down conditions. The outputs remain in the high-impedance state while the device is powered down. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without need for interface or pullup components.

	(101	VIEVV,	
OE [ 1D [ 2D [ 3D [ 5D [ 6D [ 7D ]	1 2 3 4 5 6 7 8 9	24 23 22 21 20 19 18 17	V <sub>CC</sub> 1Q 2Q 3Q 4Q 5Q 6Q
8D [ 9D [	9 10	16 15	] 8Q ] 9Q
	10 11 12	13 14 13	

#### SN54ABT843 . . . FK PACKAGE (TOP VIEW)

			2D	<del>1</del>	Ю	S	V <sub>CC</sub>	á	2Q		
	1	l									
3D	þ	5	4	3	2	1	28	27		25 C	3Q
4D		6							:	24	4Q
5D	þ	7							2	23	5Q
NC		8							:	22	NC
6D	þ	9							2	21 <b>[</b>	6Q
7D		1(	)						2	20	7Q
8D	D	11								19 <b>[</b>	8Q
			12		<u> </u>	<u> </u>	16	17	18		
			06	CLR	GND	NC NC	Щ	PRE	06		•

NC - No internal connection

OE does not affect the internal operations of the latch. Previously stored data can be retained or new data can be entered while the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54ABT843 is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to  $125^{\circ}$ C. The SN74ABT843 is characterized for operation from  $-40^{\circ}$ C to  $85^{\circ}$ C.



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

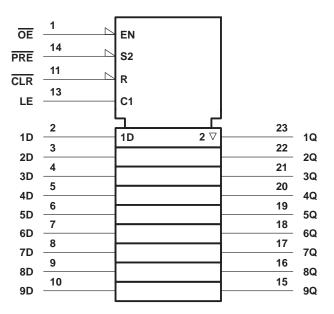


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		FUNCTI	ON TAB	LE	
		INPUTS			OUTPUT
PRE	CLR	Q			
L	Х	L	Х	Х	Н
н	L	L	Х	Х	L
н	Н	L	н	L	L
н	Н	L	н	Н	Н
н	Н	L	L	Х	Q <sub>0</sub>
Х	Х	Н	Х	Х	z

## logic symbol<sup>†</sup>

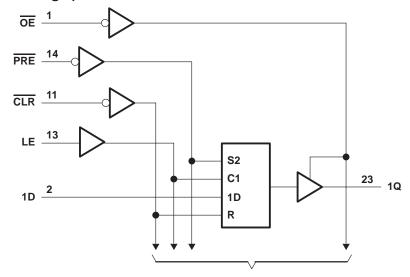


<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the DB, DW, JT, NT, and W packages.



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logic diagram (positive logic)



**To Eight Other Channels** 

Pin numbers shown are for the DB, DW, JT, NT, and W packages.

#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range , V <sub>CC</sub> Input voltage range, V <sub>I</sub> (see Note 1)	
Voltage range applied to any output in the high or power-off state, $V_{O}$	
Current into any output in the low state, I <sub>O</sub> : SN54ABT843	
SN74ABT843	
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	–18 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)	
Package thermal impedance, θ <sub>JA</sub> (see Note 2): DB package	
DW package	81°C/W
NT package	67°C/W
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions beyond those indicated in the "recommended operating conditions" section of this specification is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51, except for through-hole packages, which use a trace length of zero.



### SN54ABT843, SN74ABT843 9-BIT BUS-INTERFACE D-TYPE LATCHES WITH 3-STATE OUTPUTS SCBS197D - FEBRUARY 1991 - REVISED MAY 1997

### recommended operating conditions (see Note 3)

		SN54A	BT843	SN74A	BT843	UNIT
		MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage	4.5	5.5	4.5	5.5	V
VIH	High-level input voltage	2		2		V
VIL	Low-level input voltage		0.8		0.8	V
VI	Input voltage	0	VCC	0	VCC	V
ЮН	High-level output current		-24		-32	mA
IOL	Low-level output current		48		64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate		5		5	ns/V
Т <sub>А</sub>	Operating free-air temperature	-55	125	-40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		TEAT CONDITION		Т	A = 25°	0	SN54A	BT843	SN74ABT843		
PARAMETER		TEST CONDITIO	N5	MIN	TYP <sup>†</sup>	MAX	MIN	MAX	MIN	MAX	UNIT
VIK	V <sub>CC</sub> = 4.5 V,	lj = –18 mA				-1.2		-1.2		-1.2	V
	V <sub>CC</sub> = 4.5 V,	IOH = -3 mA		2.5			2.5		2.5		
	V <sub>CC</sub> = 5 V,	IOH = -3 mA		3			3		3		V
VOH		I <sub>OH</sub> = -24 mA					2				V
	V <sub>CC</sub> = 4.5 V	I <sub>OH</sub> = -32 mA		2*					2		
)/a.		I <sub>OL</sub> = 48 mA						0.55			V
VOL	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 64 mA				0.55*				0.55	v
V <sub>hys</sub>					100						mV
Ц	V <sub>CC</sub> = 5.5 V,	$V_{I} = V_{CC}$ or GND	)			±1		±1		±1	μΑ
<sup>I</sup> оzн <sup>‡</sup>	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.7 V				10		10		10	μΑ
I <sub>OZL</sub> ‡	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 0.5 V				-10		-10		-10	μΑ
loff	V <sub>CC</sub> = 0,	$V_{I} \text{ or } V_{O} \leq 4.5 \text{ V}$				±100				±100	μΑ
ICEX	V <sub>CC</sub> = 5.5 V,	Vo = 5.5 V	Outputs high			50		50		50	μΑ
۱ <sub>O</sub> §	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.5 V		-50	-140	-180	-50	-180	-50	-180	mA
			Outputs high		1	250		250		250	μA
ICC	$V_{CC} = 5.5 V, I_{C}$ $V_{I} = V_{CC} \text{ or } G$		Outputs low		24	34		34		34	mA
			Outputs disabled		0.5	250		250		250	μΑ
∆I <sub>CC</sub> ¶	V <sub>CC</sub> = 5.5 V, C Other inputs at	Dne input at 3.4 V, V <sub>CC</sub> or GND				1.5		1.5		1.5	mA
Ci	VI = 2.5 V or 0.	.5 V			4						pF
Co	V <sub>O</sub> = 2.5 V or 0	0.5 V			7						pF

\* On products compliant to MIL-PRF-38535, this parameter does not apply.

<sup>†</sup> All typical values are at  $V_{CC} = 5$  V.

<sup>‡</sup> The parameters I<sub>OZH</sub> and I<sub>OZL</sub> include the input leakage current.

§ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

This is the increase in supply current for each input that is at the specified TTL voltage level rather than V<sub>CC</sub> or GND.



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# timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figures 1 and 2)

				V <sub>CC</sub> =	= 5 V, 25°C	SN54A	BT843	3 SN74ABT843		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
		CLR low	CLR low			5.5		5.5		
tw	Pulse duration	PRE low	4.5		4.5		4.5		ns	
		LE low	3.3		3.3		3.4			
		Data before LE↓	Low	2.5		2.5		2.5		
	Setup time		High	3		3		3		ns
t <sub>su</sub>	Setup time	PRE inactive		1.6		1.6		1.6		115
		CLR inactive		2		2		2		
+.	Hold time, data after LE $\downarrow$	High	High			1		1		nc
th	Hold time, data after LE↓	Low		1.5†		2.3†		1.5†		ns

<sup>†</sup> This data sheet limit may vary among suppliers.

# switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figures 1 and 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C			SN54ABT843		SN74ABT843		UNIT	
			MIN	TYP	MAX	MIN	MAX	MIN	MAX		
<sup>t</sup> PLH	D	0	1.2†	3.8	5.2	1.2†	7.8	1.2†	6.7†	20	
<sup>t</sup> PHL	D	Q	1.5†	3.4	6.3	1.5†	7.3	1.5†	7.2	ns	
<sup>t</sup> PLH	LE	0	1.7†	4.4	5.6	1.7†	8.3	1.7†	7.2†	ns	
<sup>t</sup> PHL	LE	Q	1.9†	4.1	6.3	1.3†	7.2	1.9†	6.9	115	
<sup>t</sup> PLH	PRE	Q	2.2	5	6.2	2.2	8.3	2.2	7.4	ns	
<sup>t</sup> PHL	PRE	Q	2.1†	4.1	6.5	2.1†	7.5	2.1†	7.2	115	
<sup>t</sup> PLH		Q	2†	4.4	6.3	2†	7.6	2†	7.1	20	
<sup>t</sup> PHL	CLR	Q	1.9†	4.5	6.8	1.9†	8.1	1.9†	8	ns	
<sup>t</sup> PZH		0	1	3.4	4.5†	1	6.4	1	5.7†		
<sup>t</sup> PZL	OE	Q	2	4.3	5.7†	2	6.6	2	6.5	ns	
<sup>t</sup> PHZ	ŌĒ	Q	2.4†	4.9	6.2	2.4†	7.3	2.4†	6.8		
<sup>t</sup> PLZ	UE	Q	1.5†	4.2	6.3	1.5†	7	1.5†	5.9†	ns	

<sup>†</sup> This data sheet limit may vary among suppliers.



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### recovery-time waveform

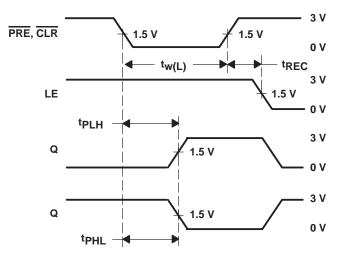
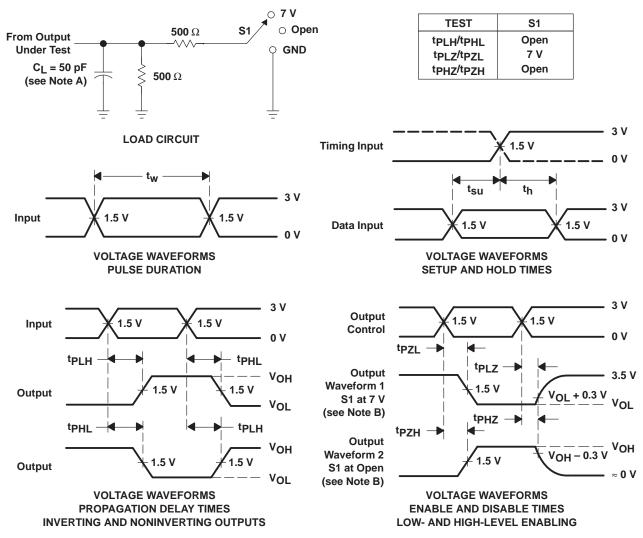


Figure 1. CLR and PRE Pulse Duration, CLR and PRE to Output Delay, and CLR and PRE to Latch-Enable Recovery Time



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#### PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z<sub>O</sub> = 50 Ω, t<sub>r</sub> ≤ 2.5 ns, t<sub>f</sub> ≤ 2.5 ns.
- C. All input pulses are supplied by generators having the rollowing characteristics: PRR  $\leq$  10 MHz, 20 = 50 Ω, t<sub>f</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns

D. The outputs are measured one at a time with one transition per measurement.

Figure 2. Load Circuit and Voltage Waveforms





### **PACKAGING INFORMATION**

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking
	(1)	(2)			(3)				(6)
5962-9571201QLA	Active	Production	CDIP (JT)   24	15   TUBE	No	(4) SNPB	<sup>(5)</sup> N/A for Pkg Type	-55 to 125	5962-9571201QL A SNJ54ABT843JT
SN74ABT843DBR	Active	Production	SSOP (DB)   24	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB843
SN74ABT843DBR.B	Active	Production	SSOP (DB)   24	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AB843
SN74ABT843DW	Active	Production	SOIC (DW)   24	25   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT843
SN74ABT843DW.B	Active	Production	SOIC (DW)   24	25   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT843
SN74ABT843DWR	Active	Production	SOIC (DW)   24	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT843
SN74ABT843DWR.B	Active	Production	SOIC (DW)   24	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ABT843
SNJ54ABT843JT	Active	Production	CDIP (JT)   24	15   TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-9571201QL A SNJ54ABT843JT

<sup>(1)</sup> **Status:** For more details on status, see our product life cycle.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.



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# PACKAGE OPTION ADDENDUM

23-May-2025

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#### OTHER QUALIFIED VERSIONS OF SN54ABT843, SN74ABT843 :

• Catalog : SN74ABT843

• Military : SN54ABT843

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

Military - QML certified for Military and Defense Applications



Texas

STRUMENTS

### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ABT843DBR	SSOP	DB	24	2000	330.0	16.4	8.2	8.8	2.5	12.0	16.0	Q1
SN74ABT843DWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1



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# PACKAGE MATERIALS INFORMATION

23-Jul-2025



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ABT843DBR	SSOP	DB	24	2000	353.0	353.0	32.0
SN74ABT843DWR	SOIC	DW	24	2000	350.0	350.0	43.0

### TEXAS INSTRUMENTS

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### TUBE



## - B - Alignment groove width

\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN74ABT843DW	DW	SOIC	24	25	506.98	12.7	4826	6.6
SN74ABT843DW.B	DW	SOIC	24	25	506.98	12.7	4826	6.6

# **MECHANICAL DATA**

MCER004A - JANUARY 1995 - REVISED JANUARY 1997

### JT (R-GDIP-T\*\*)

#### **CERAMIC DUAL-IN-LINE**

24 LEADS SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification.
- E. Falls within MIL STD 1835 GDIP3-T24, GDIP4-T28, and JEDEC MO-058 AA, MO-058 AB



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AD.



# LAND PATTERN DATA



NOTES:

A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Refer to IPC7351 for alternate board design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



# **MECHANICAL DATA**

MSSO002E - JANUARY 1995 - REVISED DECEMBER 2001

## DB (R-PDSO-G\*\*)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



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